SEMINAR WORK "SOFTWARE RELIABILITY MODELS"

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JELINSKI – MORANDA MODEL

Introduction

Since time when computers took part in our daily life software and hardware developers have to be very careful of system reliability and safety. A lot of people are not aware of how many so common things are managed by computers. If we assume for example system for medical monitoring or system in the airport the break down is not thinkable. And therefore computer reliability became one of the most important part of each system. In this way we have to consider hardware reliability but reliability of software as well. In the next text I will focus on software reliability.

Software reliability

Reliability of software is possibility of no failure during a given operating time in a specified environment. It is one of the most important software attribute. But real world programme without failure is not achievable. Commonly we can buy software which is still developing and failures are repaired in operation. Great example of this approach is operating system MS Windows which you can buy and from time to time have to dowloand pack of repairings for improving your system.

Reliability can be adressed by two ways: models and tools. Models predict reliability of a system based upon failure data whereas tools implement reliability models using software.

Models have been developed to measure, estimate and predict the reliability of computer software. It is great way how to ensure that product reliability meet the consumers needs, predict and manage costs connected with the product. Anyway more economical is to solve the problems in the phase of development then later and just models should quarantee us the cheaper solution.

At the end of software development life cycle newly creating software should be tested. Testing is complex propress. It is based on simulation and thus the test provides us data to estimate the reliability. The major goal of a software testing process is to find and fix as many deffects as possible and realease product with a reasonable reliability. We never can catch out all errors but we want to catch the majority of them.

Steps of software reliability test:

- 1. Simulation of usage in order to speciafe the usage
- 2. Statistical testing based on the specified usage
- 3. Modeling the test result to estimate current level of reliability
- 4. Prediciton, using reliability modeling

Software Reliability Models types

The models that are used in the software engineering can be divided into four classes that represent what they focus on.

Time between failures models

These types of models will be used if we need to see how the reliability changes over time. From these models we can see wheter the failure intensity increase (reliability drops and the time between failures decrease) or decrease (reliability growth and the time between failures encrease). Example of this kind is model is Jelinski – Moranda Model.

Failure count models

Models are based on the number of failures that occur in each time interval.

Failure seeding models

By seeding errors to a document and then let the document undergo testing of some kind it is possible to calculate how many "real" errors that exist.

Input domain-based

By finding all unique paths through the program and then execute each and everyone it is possible to guarantee that everything is tested.

Jelinski – Moranda model

It was introduced in 1972 for discovery and removal of faults in computer software. It is a software product test-time error detection model. The big advantage of this model is possibility to estimate total testing time which is nessesary for achivement of reliable system.

The main idea: "When the total number of remaining faults decreases as the errors are eliminated, the program should be able to run longer before a new failure occurs." Otherwise the failure intensity should decrease as time goes by.



Picture 1

In the picture 1 we can easily see the main idea of Jelinski – Moranda model. In the beginnig we have ",n" bugs and failure rate ", μ ". Step by step we remove failures and in this way ",n" decreases. At the end of process we have no failure and our system is perfectly reliable. Of course this idea is just only Utopia. System without bugs does not exist. This is that what we would like to achieve.

Jelinski – Moranda model assumptions

- The initial number of faults is constant but unknown. Faults are assumed before testing and probably these faults will cause errors during testing.
- The faults are independents of each other and equally hazardous. They have the same probability of emerging during the test.
- Faults are removed immediately in the time of emerging and any other new errors will not occur during the debug process.
- The failure rate is constant during a failure interval and it is proportional to number of faults remaining.



Picture 2 The squares mean the measured failure intesity at different times. For each removal of a fault the failure intensity decreases. We try to read from the measured

values how the failure intesity will drop and plot it.



Picture 3 From this picture we can predict how the failure intesity will develop over the time.

Failure intensity function

In the same way we can say hazard rate. This function drops by decreasing number of faults otherwise after k^{th} failure there are (N - k) faults left and the failure intensity decreases to $\mu(N - k)$.

$$\lambda i = (N-k)\mu$$

N... Finite unknown number of bugs in the software

 μFailure rate is directly proportional to the current fault content of the software

Denote by $T_i i = 1,2,3,...$ N the time between the (i-1)th and the ith failures, T_i is thus the ith failure-free time interval. T_i values are exponentially distributed random variables with parameter $\lambda i = (N - i + 1)\mu$, i = 1, 2, 3,...N.

The distribution of T_i is given by $P(T_i < t_i) = \mu(N - i + 1)\exp\{-\mu(N - i + 1)t_i\}, i=1,2,...,N$

The main property of the Jelinski – Moranda model is that the failure intensity is constant between the detection of two consecutive failures.



Picture 4 The failure intensity versus Number of removed faults

On this picture we can see the same as on the previous pictures but here the failure intensity is confronted by number of removed faults. For each removal fault the intensity rate decreases by μ .

Estimation of model parameters

We know at least 2 practical methods of parameters estimation for software reliability models. The first one is maximum-likelihood and the second one least square. For pusposes of the Jelinski – Moranda Model I will focus on maximum-likelihood method. The maximum likelihood estimates the parameters by solving a set of equations. The base of this methods is the likelihood function. Let t_i is ith failure-free time interval during the testing phase . It is time between the (i-1)th and the ith failure. The number of detected failure will be denote as "n". Suppose that the failure data set t={ $t_1, t_2, t_3, ..., t_n$; n>0} is given, the parameters N₀ and μ can be easily estimated by maximazing the likelihood function. This function of parameters N₀ and μ is given by:

$$L(t_1, t_2, \dots, t_n; N_0, \mu) = \prod_{i=1}^n \mu(N_0 - i + 1) \exp\{-\mu(N_0 - i + 1)t_i\}$$

The natural logarithm of the above likelihood function is

$$\ln L = \ln[\mu^n \{ \prod_{i=1}^n (N_0 - i + 1) \} \exp\{-\mu \sum_{i=1}^n (N_0 - i + 1)t_i \}]$$

By taking the partial derivatives of this log-likelihood function with respect to N_0 and μ respectively, and equating them to zero, we get the following likelihood equations

$$\frac{\partial \ln L}{\partial N_0} = \sum_{i=1}^n \frac{1}{N_0 - i + 1} - \sum_{i=1}^n \mu t_i = 0$$
$$\frac{\partial \ln L}{\partial \mu} = \frac{n}{\mu} - \sum_{i=1}^n (N_0 - i + 1)t_i = 0$$

Usually numerical procedures have to be used solve these two equations. However, the equation system can be simplified as follows. By solving ? from the second equation above we get

$$\mu = n \{ \sum_{i=1}^{n} (N_0 - i + 1) t_i \}^{-1}$$

and by inserting this into the first equation, we obtain an equation independent of μ

$$\frac{1}{N_0} + \frac{1}{N_0 - 1} + \dots + \frac{1}{N_0 - n + 1} = \frac{n \sum_{i=1}^n t_i}{\sum_{i=1}^n (N_0 - i + 1)t_i}$$

The estimate of N can then be obtained by solving this equation. Inserting the estimated N_0 into the expression of μ , we may then get the maximum likelihood estimate of μ .

PRACTICAL PART

CASRE

For showing practical utilization of the Jelinski – Moranda model I decided to use the program "CASRE". This program is free downloaded on the Internet on <u>https://www.openchannelfoundation.org</u>. CASRE is abreviation of Computer Aided Software Realiability Estimation. It was developed as a software reliability measurement tool which is easy to use for nonspecialists in software reliability engineering. Two file formats of input are allowed:

- Time Between Failures (error #, time since last failure, error severity)
- Failure Counts (interval #, # errors in interval, interval length, error severity)

Program outputs are different graphs and calculations of different indicators. We can choose from different models.:

Time between failure models

- Geometric
- Jelinski-Moranda
- Littlewood-Verrall
- Musa-Basic
- Musa-Okumoto
- NHPP

Failure Count models

- Generalized Poisson
- NHPP
- Schneidewind
- Shick-Wolverton
- Yamada S-shaped

CASRE benefits

- The CASRE user interface is fairly user friendly. Mechanisms such as "parameter estimation", make it easier to use the various reliability models.

- The ability to combine the results of several models is a powerful feature.

- Results are available in tabular and graphical formats.
- Can apply various filters and noise reduction functions to effect the shape of the input data.

Input

The data from table 1 was used as an input to CASRE. The data has to be in an exact text

format data.txt and the file has to have the extension ".dat". For the purposes of the Jelinsky – Moranda model we use the input format "Time Between Failure".

Output

In the graph 1 the Cumulative Time Between Failures (CTBF) was plot from the data. Reliability is increasing if the Mean Time Between Failures (MTBF) is increasing as the total number of failures accumulates during the testing phase. In the graph 1 we can see that the slope of CTBF grows still more slowly as the total number of failures accumulates during testing. So that means that CTBF is decreasing as time goes by due to fact that the MTBF is increasing.

In the graph 2 we can see the failure intensity which is supposed to be decreasing.

In the graph 3 the Time Between Failure is ploted which was around 8 hours at the end of the testing period .

Finally the program offers us the overview of all estimate for the given model (in our case the Jelinski – Moranda model) in the table 2.

Conclusion

The software needs to be tested for approximately an additional 54 hours before its release to achieve the failure intensity of 0,084 faults/hour, which can be supposed to be satisfactory.

Date	Time	Cumulative Execution Time	Time Between Failures	Fault Description	Fault Severity
Sept 5, 2001	9:30 AM	0.50 hours	0.50 hours	GUI Warning Message Error	Low (1)
Sept 5, 2001	9:45 AM	0.75 hours	0.25 hours	Calculation Engine Error	High (9)
Sept 5, 2001	10:00 AM	1.00 hours	0.25 hours	Output Report Error	Low (1)
Sept 5, 2001	10:30 AM	1.50 hours	0.50 hours	Output Report Error	Low (1)
Sept 5, 2001	11:15 AM	2.25 hours	0.75 hours	GUI Schematic Diagram Error	Medium (5)
Sept 5, 2001	1:15 PM	3.25 hours	1.0 hours	GUI Fatal Error	High (9)
Sept 5, 2001	1:45 PM	3.75 hours	0.50 hours	Calculation Engine Error	High (9)
Sept 5, 2001	2:30 PM	4.50 hours	0.75 hours	GUI Warning Message Error	Low (1)
Sept 5, 2001	3:15 PM	5.25 hours	0.75 hours	Output Report Error	Medium (5)
Sept 5, 2001	3:30 PM	5.50 hours	0.25 hours	GUI Dialog Screen Error	Medium (5)
Sept 5, 2001	4:00 PM	6.00 hours	0.50 hours	GUI Dialog Screen Error	Low (1)
Sept 5, 2001	4:30 PM	6.50 hours	0.50 hours	Calculation Engine Error	High (9)
Sept 6, 2001	10:00 AM	8.00 hours	1.5 hours	Output Report Error	Low (1)
Sept 6, 2001	11:15 AM	9.25 hours	1.25 hours	GUI Warning Message Error	Low (1)
Sept 6, 2001	2:00 PM	11.00 hours	1.75 hours	Output Report Error	Low (1)
Sept 6, 2001	3:30 PM	12.50 hours	1.50 hours	Calculation Engine Error	High (9)
Sept 6, 2001	4:15 PM	13.25 hours	0.75 hours	Output Report Error	Low (1)
Sept 7, 2001	9:15 AM	14.25 hours	1.00 hours	Output Report Error	Low (1)
Sept 7, 2001	11:45 AM	16.25 hours	2.00 hours	GUI Warning Message Error	Low (1)
Sept 7, 2001	3:00 PM	18.50 hours	2.25 hours	Calculation Engine Error	High (9)

Sept 7, 2001	4:15 PM	19.75 hours	1.25 hours	GUI Dialog Screen Error	Medium (5)
Sept 17, 2001	10:00 AM	22.00 hours	2.25 hours	GUI Dialog Screen Error	Low (1)
Sept 17, 2001	11:30 AM	23.50 hours	1.50 hours	Calculation Engine Error	Medium (5)
Sept 17, 2001	2:15 PM	25.25 hours	1.75 hours	GUI Dialog Screen Error	Low (1)
Sept 17, 2001	3:45 PM	26.75 hours	1.50 hours	GUI Dialog Screen Error	Low (1)
Sept 18, 2001	9:15 AM	28.75 hours	2.00 hours	GUI Schematic Diagram Error	Low (1)
Sept 18, 2001	11:30 AM	31.00 hours	2.25 hours	GUI Dialog Screen Error	Low (1)
Sept 18, 2001	3:30 PM	34.00 hours	3.00 hours	Calculation Engine Error	Medium (5)
Sept 19, 2001	1:30 PM	38.50 hours	4.50 hours	Output Report Error	Low (1)
Sept 19, 2001	11:00 AM	44.00 hours	5.50 hours	GUI Dialog Screen Error	Low (1)
Sept 19, 2001	1:30 PM	52.00 hours	8.00 hours	GUI Dialog Screen Error	Low (1)

Table 1











										low 95% value:	low 95% value:	low 95% value:	Most likely:
Failure no.	Hours since	Next step	Model	Elapsed time T	Est. reliability:	Est'd cumulative	Failure intensity	Actuals-Estimates	Did Estimates	Proportional-	Hazard	Total	Proportional-
	last failure	Prediction	Estimates	from test start	8.00000e+000 Hr	failures by T	at elapsed time T		Converge?	ity constant	rate	Failures	ity constant
1	5.00000e-001	N/A	5.56451e-001 5	5.00000e-001	1.25913e-005	8.86157e-001	1.74775e+000	-5.64505e-002	N/A	N/A	N/A	N/A	N/A
2	2.50000e-001	N/A	5.74247e-001 /	1.00000e-001	1.4/1/00-000	1.32007e+000	1.72309e+000	-3.24247e-001	N/A	N/A	N/A	N/A	N/A
3	2.00000e-001	N/A N/A	0.00210e-001 1	1.00000e+000	1./164/e-000	1.74750e+000	1.655750+000	-3.43219e-001	N/A	N/A	N/A N/A	N/A	N/A
5	7.50000e-001	N/A	6.134002-001	2 25000e+000	2.32003e-005	2.00013e+000	1.655070+000	1.134000-001	N/A	N/A	N/A N/A	N/A	N/A
6	1.00000e+000	N/A	6.58486e-001 2	2.25000e+000	6 2501/e-005	5.30040e+000	1.000400+000	3 41514e-001	N/A	N/A	N/A	N/A	N/A
7	5.00000e-001	N/A	6.83555e-001 3	3.25000e+000	8 15355e-005	6.08194e+000	1.45938e+000	-1.835556-001	N/A	N/A	N/A	N/A	N/A
8	7 50000e-001	N/A	7 10607e-001	1 500000+000	1 198/3e-00/	7 15319e+000	1 39872e+000	3 939270-002	N/A	N/A	N/A	N/A	N/A
9	7.50000e-001	N/A	7.39890e-001	5 25000e+000	1 73396e-004	8 18062e+000	1 34149e+000	1 01104e-002	N/A	N/A	N/A	N/A	N/A
10	2.50000e-001	N/A	7.71689e-001	5.50000e+000	1.95452e-004	8.51367e+000	1.32294e+000	-5.21689e-001	N/A	N/A	N/A	N/A	N/A
11	5.00000e-001	N/A	8.06344e-001 6	6.00000e+000	2.47115e-004	9.16602e+000	1.28661e+000	-3.06344e-001	N/A	N/A	N/A	N/A	N/A
12	5.00000e-001	N/A	8.44259e-001 0	6.50000e+000	3.10428e-004	9.80045e+000	1.25128e+000	-3.44259e-001	N/A	N/A	N/A	N/A	N/A
13	1.50000e+000	N/A	8.85914e-001 8	8.00000e+000	5.93087e-004	1.16011e+001	1.15099e+000	6.14086e-001	N/A	N/A	N/A	N/A	N/A
14	1.25000e+000	N/A	9.31894e-001 9	9.25000e+000	9.77517e-004	1.29909e+001	1.07359e+000	3.18106e-001	N/A	N/A	N/A	N/A	N/A
15	1.75000e+000	N/A	9.82908e-001 1	1.10000e+001	1.86053e-003	1.47810e+001	9.73890e-001	7.67092e-001	N/A	N/A	N/A	N/A	N/A
16	1.50000e+000	2.12735e+000	1.03983e+000 1	1.25000e+001	3.07940e-003	1.61825e+001	8.95836e-001	4.60170e-001	YES	N/A	N/A	N/A	1.24223e-001
17	7.50000e-001	1.80505e+000	1.10375e+000 1	1.32500e+001	3.90134e-003	1.68406e+001	8.59187e-001	-3.53751e-001	YES	N/A	N/A	N/A	1.01947e-001
18	1.00000e+000	1.72305e+000	1.17605e+000 1	1.42500e+001	5.26867e-003	1.76763e+001	8.12644e-001	-1.76045e-001	YES	N/A	N/A	N/A	8.92641e-002
19	2.00000e+000	2.20267e+000	1.25847e+000 1	1.62500e+001	9.15910e-003	1.92143e+001	7.26985e-001	7.41526e-001	YES	N/A	N/A	N/A	9.27951e-002
20	2.25000e+000	2.80269e+000	1.35333e+000 1	1.85000e+001	1.59185e-002	2.07517e+001	6.41362e-001	8.96672e-001	YES	N/A	N/A	N/A	9.32118e-002
21	1.25000e+000	2.62654e+000	1.46365e+000 1	1.97500e+001	2.10292e-002	2.15261e+001	5.98231e-001	-2.13646e-001	YES	N/A	N/A	N/A	8.24501e-002
22	2.25000e+000	3.08960e+000	1.59355e+000 2	2.20000e+001	3.31404e-002	2.27912e+001	5.27772e-001	6.56455e-001	YES	N/A	N/A	N/A	8.02121e-002
23	1.50000e+000	2.99101e+000	1.74875e+000 2	2.35000e+001	4.35457e-002	2.35507e+001	4.85473e-001	-2.48748e-001	YES	N/A	N/A	N/A	7.24551e-002
24	1.75000e+000	3.03922e+000	1.93745e+000 2	2.52500e+001	5.82560e-002	2.43602e+001	4.40389e-001	-1.8/445e-001	YES	N/A	N/A	N/A	6.69880e-002
25	1.50000e+000	2.93525e+000	2.17179e+000 2	2.67500e+001	7.31634e-002	2.49939e+001	4.05094e-001	-6.71790e-001	YES	N/A	N/A	N/A	6.08683e-002
26	2.20000e+000	3.18006e+000	2.47063e+000 2	2.89500e+001	9.89148e-002	2.58327e+001	3.58379e-001	-2.70627e-001	YES	N/A	N/A	N/A	5.82735e-002
27	2.25000e+000	3.401/3e+000	2.86482e+000 3	3.12000e+001	1.29896e-001	2.65906e+001	3.161/0e-001	-6.14823e-001	YES	N/A	N/A	N/A	5.55136e-002
28	3.00000e+000	3.96/49e+000	3.40869e+000 3	3.42000e+001	1.778238-001	2.746410+001	2.670210-001	-4.08692e-001	TES	N/A	N/A N/A	N/A	5.45376e-002
29	4.00000e+000	3.42373e+000 7.92202e+000	4.20745e+000 3	42000e+001	2.007000-001	2.002030+001	2.00210e-001	2.52001e-001	VES	N/A	N/A N/A	N/A	5.546710-002
24	9.00000e+000	1.032030+000	7 91955-+000	4.42000e+001	5.71765e-001	2.551550+001	0.032750-001	4.00323e-003 9.14524o.002	VES	N/A	N/A N/A	N/A	5.557676-002
32	N/A	N/A	1.41659e+000	5.48100e+001	5781070-001	3.07/33e+001	8 /8891e-002 <	N/A	N/A	N/A	N/A	N/A	0.00040E-002
02	100	100	1.410000-1001	0.4010021001		0.014002.001	0.400010-002		n/A	100	na		100
			Most like	ely: Most li	kely: high 95	% value: high 95	% value: high 95	% value:					
			Hazard	l lotal	Proport	ional- Haza	rd lotal	-1 * In(P	L) U(I)	y(i)			
			Tate	Fallu	es ity cons	tant rate	Fallui	62					
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			
			4.70067e-0	01 1.978410	e+001 N/A	N/A	N/A	1.1074361	+000 2.9/10/e	001 3.075226	-002		
			5.902660.0	01 2.243420	27001 N/A	N/A	N/A	2.202020	+000 4.253538	001 7.507656	2-002		
			1.53995e-0	101 2.45017	2+001 N/A	N/A	N/A	5.76801e	+000 6.007436	001 1.60325	2-001		
			3.56800e-0	101 2.38278	+001 N/A	N/A	N/A	7 2//596	+000 3.59816e	.001 3.083314	-001		
			3 80729e-0	01 2.56177	e+001 N/A	N/A	N/A	9.06689e	+000 5 75414e	001 3 83054	a-001		
			3.23666e-0	01 2.60351	e+001 N/A	N/A	N/A	1.06804e	+001 3.84610e	001 4.25403	-001		
			3.34336e-0	001 2.76144	e+001 N/A	N/A	N/A	1.23611e	+001 4.42943e	001 4.76439	e-001		
			3.29032e-0	001 2.89118	e+001 N/A	N/A	N/A	1.39663e	+001 3.89543e	001 5.19490	e-001		
			3.40687e-0	001 3.05971	e+001 N/A	N/A	N/A	1.57926e	+001 5.27402e	001 5.84868	e-001		
			3.14460e-0	001 3.13963	e+001 N/A	N/A	N/A	1.76570e	+001 5.07142e	001 6.46585	e-001		
			2.93968e-0	001 3.22954	e+001 N/A	N/A	N/A	1.97632e	+001 5.86007e	001 7.23511	e-001		
			2.52048e-0	001 3.26216	e+001 N/A	N/A	N/A	2.22756e	+001 6.78326e	001 8.22447	e-001		
			1.84375e-0	001 3.23228	e+001 N/A	N/A	N/A	2.49804e	+001 6.37258e	001 9.10901	2-001		
			1.27681e-0	001 3.22974	e+001 N/A	N/A	N/A	2.80601e	+001 6.39926e	001 1.00000	e+000		
			7.05918e-0	3.22675	e+001 N/A	N/A	N/A	N/A	N/A	N/A			
			N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A			

Table 2 – Model results table

OTHERS MODELS

Software Reliability Growth Models

These models rely on observation of failure occurrence and try to predict future failure behavior. Here are two examples of these models

- Musa's Basic Model
- Musa/Okumoto Logarithmic Model

General assumptions:

- Faults are independent and distributed with constant rate of encounter
- Execution time between failures is large compare to instruction execution time
- All failures are observed
- Fault causing failure is corrected immidiately and reoccurance of this failure is not counted

Musa's Basic Model

Assumption: Decrement in failure intensity function is constant.

Consequence: Failure intensity is function of average number of failures experienced at every given point in time(=failure probability).

$$\lambda(\mu) = \lambda_0 \left[1 - \frac{\mu}{\nu_0} \right]$$

- $\lambda(\mu)$: failure intensity
- λ_0 : initial failure intensity at start of execution
- μ : average total number of failures at a given point in time
- v_0 : total number of failures over infinite time

Musa/Okumoto Logarithmic Poisson Model

This model uses a failure intensity decay parameter (instead of the total failures expected, which is used in Musa's basic model). The decrement per failure for the logarithmic Poisson model is smaller each time a failure is experienced.

$$\lambda(\mu) = \lambda_0 e^{-\theta\mu}$$

 θ : failure intensity decay parameter

Comparison of these models

Basic model assumes that there is a 0 failure intensity while logaritmic model assumes convergence to 0 failure intensity.

Basic model assumes finite number of failures in the system while logaritmic model assumes infinite number.

Parametr estimations are usually obtained from system test observation and operational system by comparison with values from similar projects.

Failure count models

Group of models that are based on the number of failures that occur in each time interval. One subgroup of these models is the NonHomogeneous Poisson Process models (NHPP), firstly proposed by Goel and Okumoto in 1979, which has formed the basis for the failure count models.

The Goel-Okumoto model

Assumptions:

- The cumulative number of faults detected at time t follows Poisson distribution
- All faults are independent and have the same chance of being detected
- All detected faults are removed immidiately and no new faults are introducedas

The Goel-Okumoto model assumes that the failure process is modeled by an NHPP models with the mean value function $\mu(t)$ given by

$$\mu(t) = a(1 - e^{-bt})$$

Where a > 0 and b > 0, *a* is the expected total number of faults and *b* is the "shape" factor. The failure intensity is $\lambda(t) = abe^{-bt}$ which is equal to the derivate of $\mu(t)$.

Error sendings models

Mills error sending model

Mills propose a method to estimate the number of errors in a program by introducing "psedo-errors" into the program. From the debugging data, which consists of indigenous errors and induced errors, the unknown number of indigenous errors can be estimated. This model can be represented by a hypergeometric distribution.

The probability of k induced errors in r removed errors follows a hypogeometric distribution.

$$P(k; N+n_1; n_1, r) = \frac{\binom{n_1}{k}\binom{N}{r-k}}{\binom{N+n_1}{r}}$$

where

N = number of indigenous errors

 $n_1 =$ number of induced errors

r = number of errors removed during debugging

k = number of induced errors in r removed errors

r-k = number of indigenous errors in r removed errors.

Since n_1 , r and k are known, the maximum likelihood estimate of N can be shown as

$$N = \frac{n_1(r-k)}{k}$$

But this method was criticised for its inability to determine the type, location and difficulty level of the induced errors such that they would likely to be detected equally likely as the indigenous errors.

$$P(k; N + n_1; n_1, r) = \frac{\binom{n_1}{\binom{N}{r-k}}}{\binom{N}{\binom{N}{r}}}$$

And the maximum likelihood estimate of *N* was modified to:

$$N = \frac{n_1 r}{k}$$

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